

## MOSFET

### 600V CoolMOS™ CE Power Transistor

CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. CoolMOS™ CE is a price-performance optimized platform enabling to target cost sensitive applications in Consumer and Lighting markets by still meeting highest efficiency standards. The new series provides all benefits of a fast switching Superjunction MOSFET while not sacrificing ease of use and offering the best cost down performance ratio available on the market.

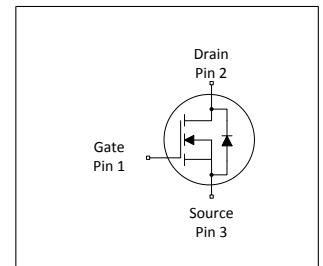
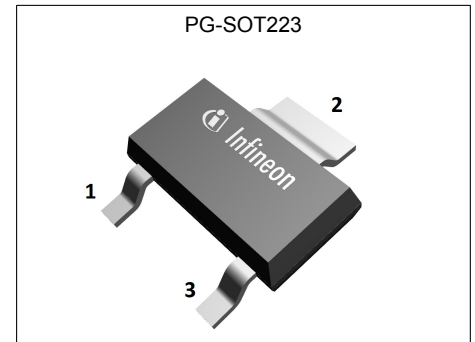
### Features

- Extremely low losses due to very low FOM  $R_{DS(on)} \cdot Q_g$  and  $E_{oss}$
- Very high commutation ruggedness
- Easy to use/drive
- Pb-free plating, Halogen free mold compound
- Qualified for standard grade applications

### Applications

Adapter, Charger and Lighting

*Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.*



**Table 1 Key Performance Parameters**

| Parameter            | Value | Unit       |
|----------------------|-------|------------|
| $V_{DS} @ T_{j,max}$ | 650   | V          |
| $R_{DS(on),max}$     | 1     | $\Omega$   |
| $Q_{g,typ}$          | 13    | nC         |
| $I_{D,pulse}$        | 11.8  | A          |
| $E_{oss}@400V$       | 1.3   | $\mu J$    |
| Body diode $di/dt$   | 500   | A/ $\mu s$ |

| Type / Ordering Code | Package   | Marking | Related Links  |
|----------------------|-----------|---------|----------------|
| IPN60R1K0CE          | PG-SOT223 | 60S1K0  | see Appendix A |

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## 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                                     | Symbol         | Values     |      |            | Unit             | Note / Test Condition   |
|---|----------------|------------|------|------------|------------------|---|
|   |                | Min.       | Typ. | Max.       |                  |   |
| Continuous drain current <sup>1)</sup>        | $I_D$          | -          | -    | 6.8<br>4.3 | A                | $T_C = 25^\circ\text{C}$<br>$T_C = 100^\circ\text{C}$                       |
| Pulsed drain current <sup>2)</sup>            | $I_{D,pulse}$  | -          | -    | 11.8       | A                | $T_C = 25^\circ\text{C}$  |
| Avalanche energy, single pulse                | $E_{AS}$       | -          | -    | 46         | mJ               | $I_D = 0.8\text{A}$ ; $V_{DD} = 50\text{V}$                                 |
| Avalanche energy, repetitive                  | $E_{AR}$       | -          | -    | 0.13       | mJ               | $I_D = 0.8\text{A}$ ; $V_{DD} = 50\text{V}$                                 |
| Avalanche current, repetitive                 | $I_{AR}$       | -          | -    | 0.8        | A                | -   |
| MOSFET dv/dt ruggedness                       | dv/dt          | -          | -    | 50         | V/ns             | $V_{DS} = 0\dots480\text{V}$  |
| Gate source voltage                           | $V_{GS}$       | -20<br>-30 | -    | 20<br>30   | V                | static;<br>AC ( $f > 1\text{ Hz}$ )   |
| Power dissipation                             | $P_{tot}$      | -          | -    | 5.0        | W                | $T_C = 25^\circ\text{C}$  |
| Operating and storage temperature             | $T_j, T_{stg}$ | -40        | -    | 150        | $^\circ\text{C}$ | -   |
| Continuous diode forward current              | $I_S$          | -          | -    | 1.4        | A                | $T_C = 25^\circ\text{C}$  |
| Diode pulse current <sup>2)</sup>             | $I_{S,pulse}$  | -          | -    | 11.8       | A                | $T_C = 25^\circ\text{C}$  |
| Reverse diode dv/dt <sup>3)</sup>             | dv/dt          | -          | -    | 15         | V/ns             | $V_{DS} = 0\dots400\text{V}$ , $I_{SD} \leq I_S$ , $T_j = 25^\circ\text{C}$ |
| Maximum diode commutation speed <sup>3)</sup> | di/dt          | -          | -    | 500        | A/ $\mu\text{s}$ | $V_{DS} = 0\dots400\text{V}$ , $I_{SD} \leq I_S$ , $T_j = 25^\circ\text{C}$ |

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter  | Symbol     | Values |      |      | Unit               | Note / Test Condition   |
|--|------------|--------|------|------|--------------------|---|
|  |            | Min.   | Typ. | Max. |                    |   |
| Thermal resistance, junction - solder point                    | $R_{thJS}$ | -      | -    | 23.2 | $^\circ\text{C/W}$ | -   |
| Thermal resistance, junction - ambient for minimal footprint   | $R_{thJA}$ | -      | -    | 160  | $^\circ\text{C/W}$ | minimal footprint   |
| Thermal resistance, junction - ambient soldered on copper area | $R_{thJA}$ | -      | -    | 75   | $^\circ\text{C/W}$ | Device on 40mm*40mm*1.5 epoxy PCB FR4 with 6cm <sup>2</sup> (one layer 70 $\mu\text{m}$ thick) copper area for drain connection and cooling. PCB is vertical without blown air. |
| Soldering temperature, wavesoldering only allowed at leads     | $T_{sold}$ | -      | -    | 260  | $^\circ\text{C}$   | reflow MSL3   |

<sup>1)</sup> DPAK equivalent. Limited by  $T_{j,max}$ . Maximum duty cycle  $D=0.5$

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$

<sup>3)</sup>  $V_{DClink}=400\text{V}$ ;  $V_{DS,peak} < V_{(BR)DSS}$ ; identical low side and high side switch with identical  $R_G$

### 3 Electrical characteristics

**Table 4 Static characteristics**

| Parameter                        | Symbol        | Values |      |      | Unit     | Note / Test Condition   |
|----------------------------------|---------------|--------|------|------|----------|---|
|                                  |               | Min.   | Typ. | Max. |          |   |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 600    | -    | -    | V        | $V_{GS}=0V, I_D=0.25mA$   |
| Gate threshold voltage           | $V_{GS(th)}$  | 2.50   | 3    | 3.50 | V        | $V_{DS}=V_{GS}, I_D=0.13mA$   |
| Zero gate voltage drain current  | $I_{DSS}$     | -      | -    | 1    | $\mu A$  | $V_{DS}=600V, V_{GS}=0V, T_j=25^\circ C$<br>$V_{DS}=600V, V_{GS}=0V, T_j=150^\circ C$ |
| Gate-source leakage current      | $I_{GSS}$     | -      | -    | 100  | nA       | $V_{GS}=20V, V_{DS}=0V$   |
| Drain-source on-state resistance | $R_{DS(on)}$  | -      | 0.90 | 1.00 | $\Omega$ | $V_{GS}=10V, I_D=1.5A, T_j=25^\circ C$<br>$V_{GS}=10V, I_D=1.5A, T_j=150^\circ C$     |
| Gate resistance                  | $R_G$         | -      | 16   | -    | $\Omega$ | $f=1\text{ MHz, open drain}$  |

**Table 5 Dynamic characteristics**

| Parameter  | Symbol       | Values |      |      | Unit | Note / Test Condition                                    |
|--|--------------|--------|------|------|------|--|
|  |              | Min.   | Typ. | Max. |      |  |
| Input capacitance  | $C_{iss}$    | -      | 280  | -    | pF   | $V_{GS}=0V, V_{DS}=100V, f=1MHz$                         |
| Output capacitance   | $C_{oss}$    | -      | 21   | -    | pF   | $V_{GS}=0V, V_{DS}=100V, f=1MHz$                         |
| Effective output capacitance, energy related <sup>1)</sup> | $C_{o(er)}$  | -      | 14   | -    | pF   | $V_{GS}=0V, V_{DS}=0...480V$                             |
| Effective output capacitance, time related <sup>2)</sup>   | $C_{o(tr)}$  | -      | 57   | -    | pF   | $I_D=constant, V_{GS}=0V, V_{DS}=0...480V$               |
| Turn-on delay time   | $t_{d(on)}$  | -      | 10   | -    | ns   | $V_{DD}=400V, V_{GS}=13V, I_D=1.9A,$<br>$R_G=12.2\Omega$ |
| Rise time  | $t_r$        | -      | 8    | -    | ns   | $V_{DD}=400V, V_{GS}=13V, I_D=1.9A,$<br>$R_G=12.2\Omega$ |
| Turn-off delay time  | $t_{d(off)}$ | -      | 60   | -    | ns   | $V_{DD}=400V, V_{GS}=13V, I_D=1.9A,$<br>$R_G=12.2\Omega$ |
| Fall time  | $t_f$        | -      | 13   | -    | ns   | $V_{DD}=400V, V_{GS}=13V, I_D=1.9A,$<br>$R_G=12.2\Omega$ |

**Table 6 Gate charge characteristics**

| Parameter             | Symbol        | Values |      |      | Unit | Note / Test Condition                           |
|-----------------------|---------------|--------|------|------|------|---|
|                       |               | Min.   | Typ. | Max. |      |   |
| Gate to source charge | $Q_{gs}$      | -      | 1.5  | -    | nC   | $V_{DD}=480V, I_D=1.9A, V_{GS}=0\text{ to }10V$ |
| Gate to drain charge  | $Q_{gd}$      | -      | 6.5  | -    | nC   | $V_{DD}=480V, I_D=1.9A, V_{GS}=0\text{ to }10V$ |
| Gate charge total     | $Q_g$         | -      | 13   | -    | nC   | $V_{DD}=480V, I_D=1.9A, V_{GS}=0\text{ to }10V$ |
| Gate plateau voltage  | $V_{plateau}$ | -      | 5.4  | -    | V    | $V_{DD}=480V, I_D=1.9A, V_{GS}=0\text{ to }10V$ |

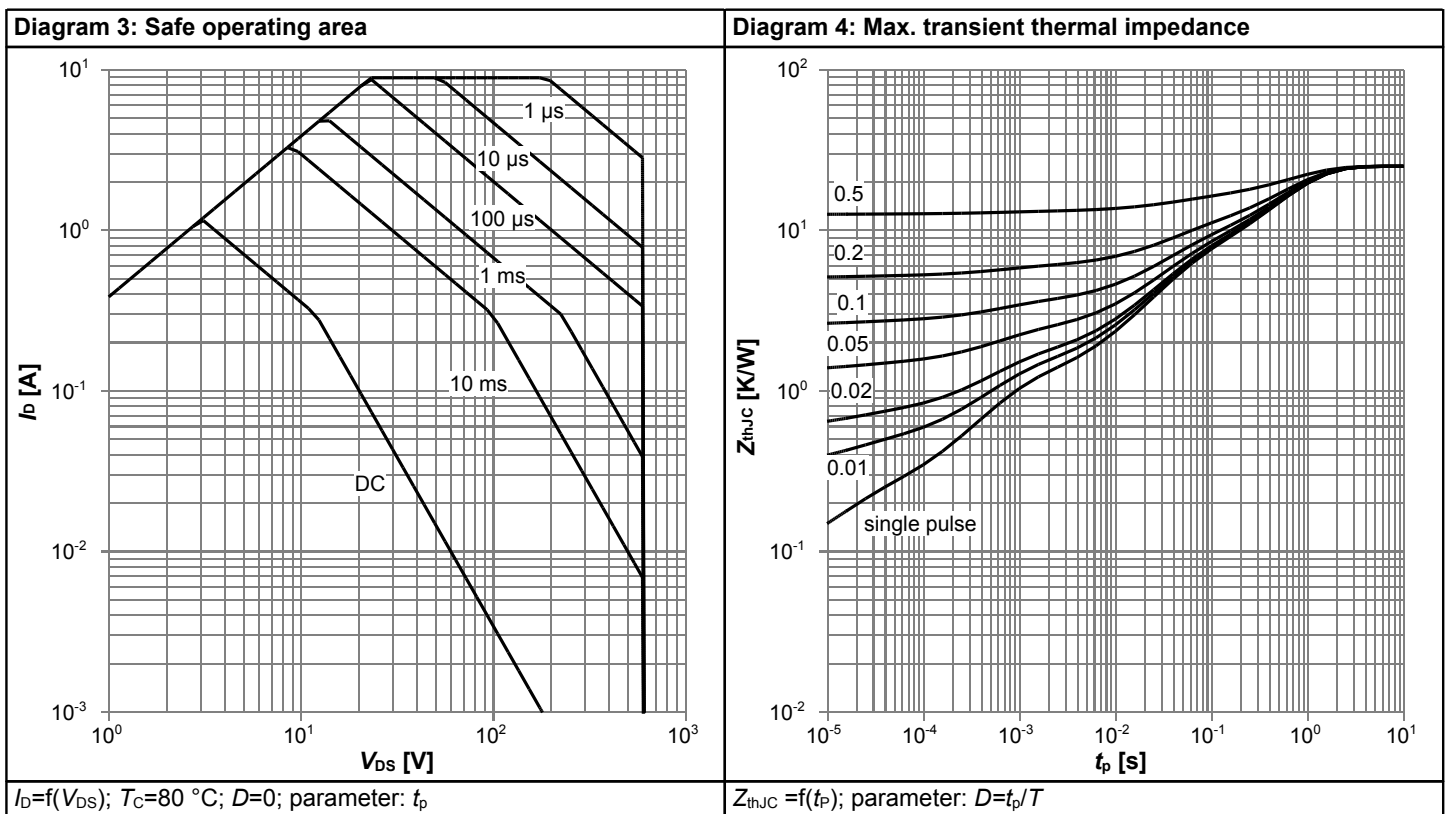
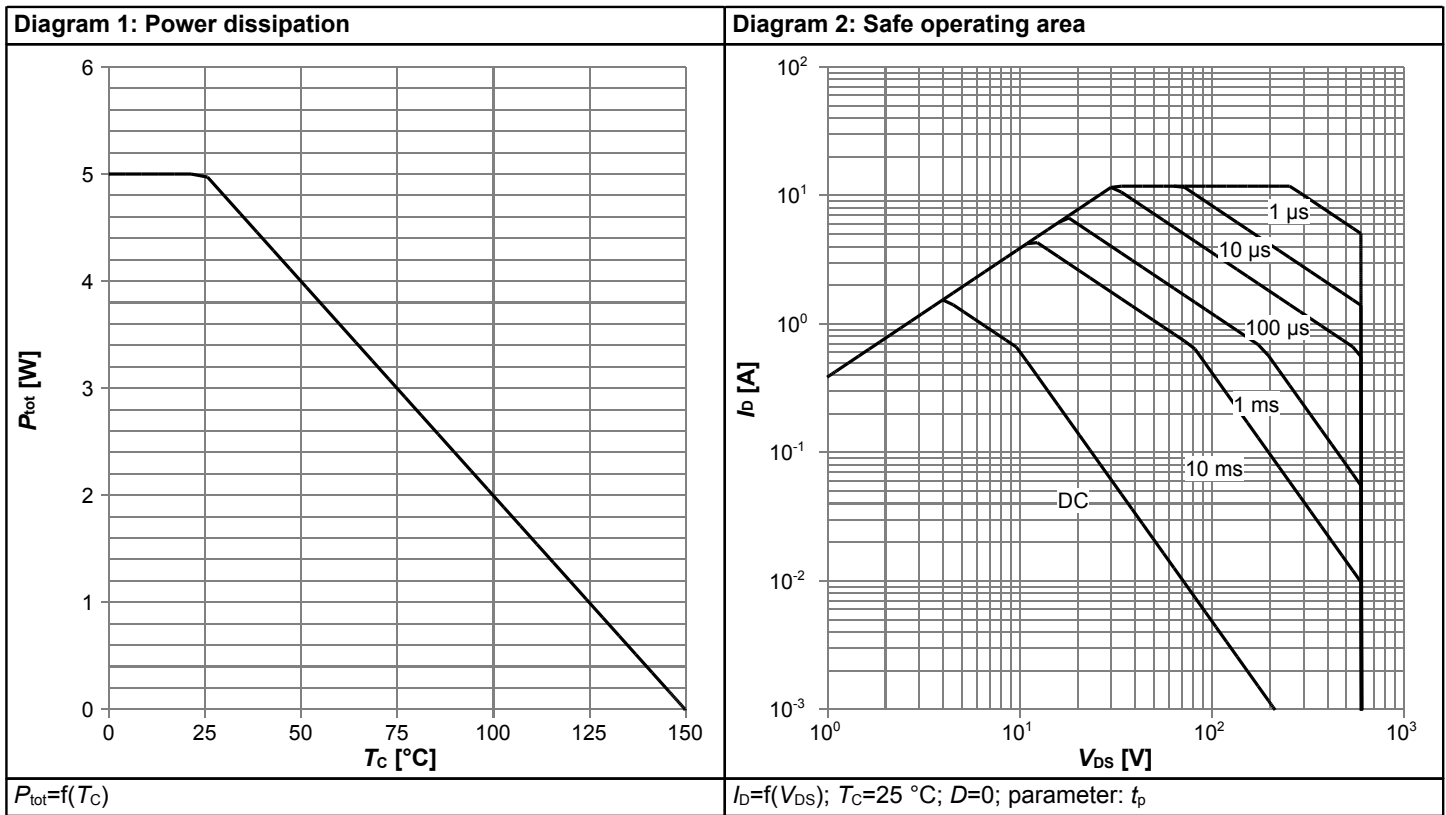
<sup>1)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 480V

<sup>2)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 480V

Table 7 Reverse diode characteristics

| Parameter                     | Symbol    | Values |      |      | Unit    | Note / Test Condition                    |
|-------------------------------|-----------|--------|------|------|---------|--|
|                               |           | Min.   | Typ. | Max. |         |  |
| Diode forward voltage         | $V_{SD}$  | -      | 0.9  | -    | V       | $V_{GS}=0V, I_F=1.9A, T_i=25^{\circ}C$   |
| Reverse recovery time         | $t_{rr}$  | -      | 220  | -    | ns      | $V_R=400V, I_F=1.9A, di_F/dt=100A/\mu s$ |
| Reverse recovery charge       | $Q_{rr}$  | -      | 1.5  | -    | $\mu C$ | $V_R=400V, I_F=1.9A, di_F/dt=100A/\mu s$ |
| Peak reverse recovery current | $I_{rrm}$ | -      | 12   | -    | A       | $V_R=400V, I_F=1.9A, di_F/dt=100A/\mu s$ |

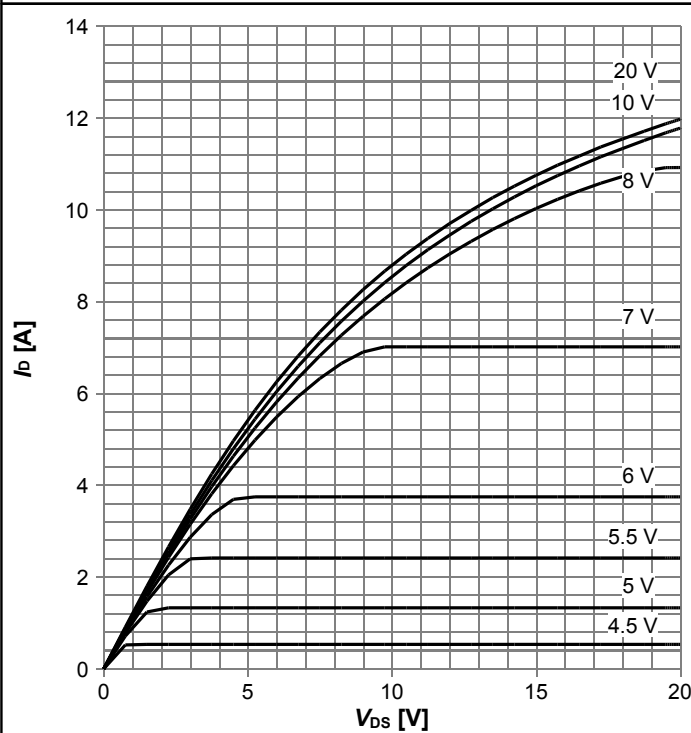
### 4 Electrical characteristics diagrams



# 600V CoolMOS™ CE Power Transistor

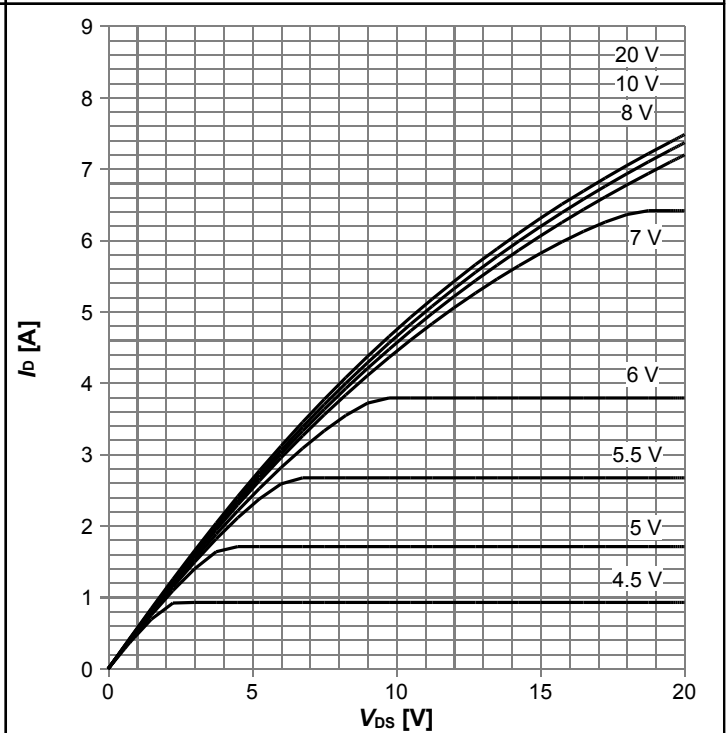
## IPN60R1K0CE

Diagram 5: Typ. output characteristics



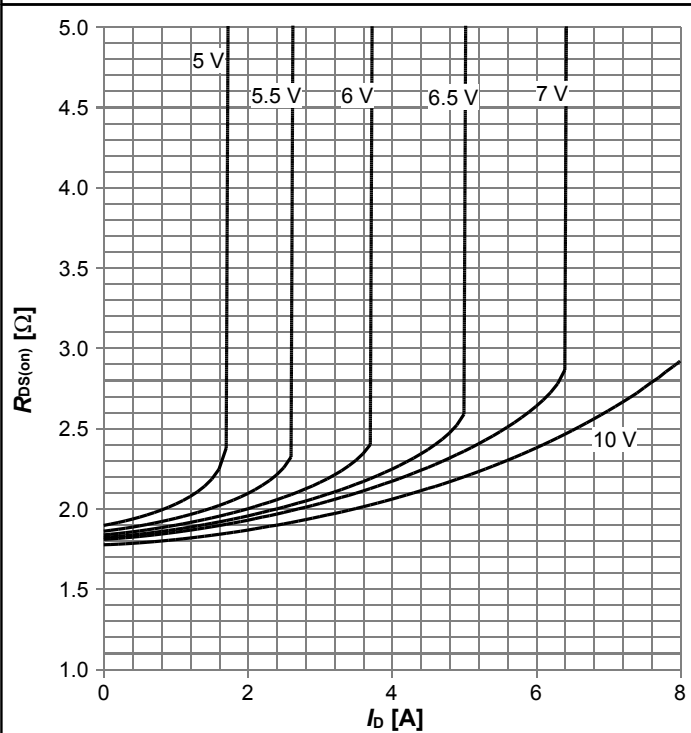
$I_D=f(V_{DS})$ ;  $T_j=25\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. output characteristics



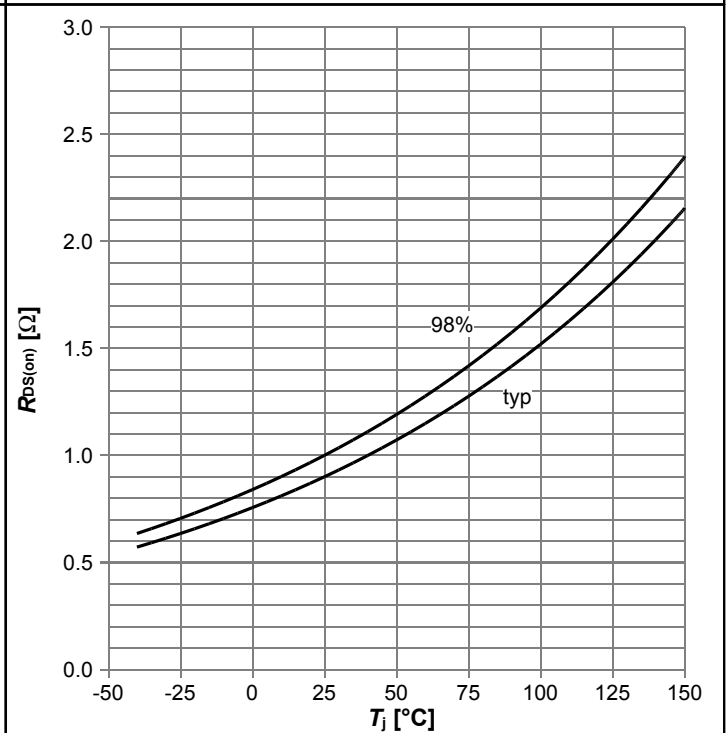
$I_D=f(V_{DS})$ ;  $T_j=125\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. drain-source on-state resistance



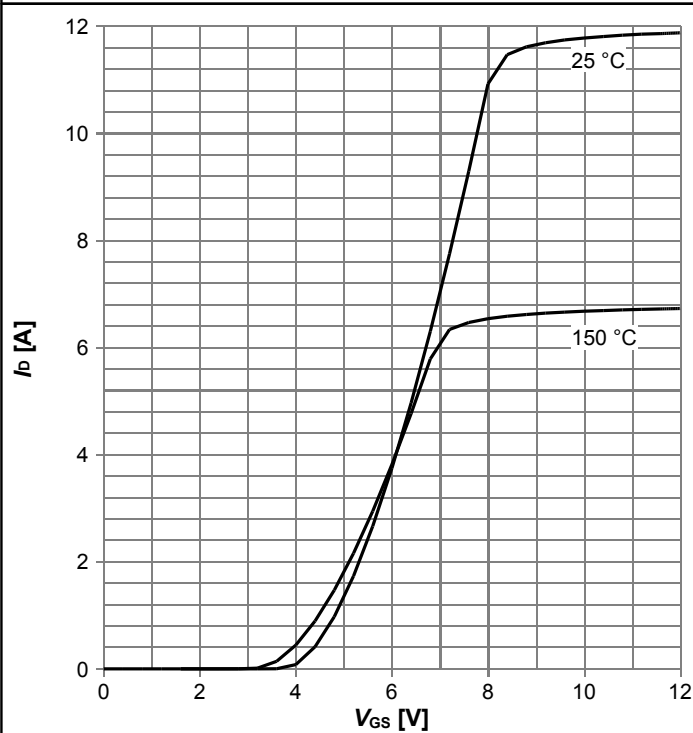
$R_{DS(on)}=f(I_D)$ ;  $T_j=125\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 8: Drain-source on-state resistance



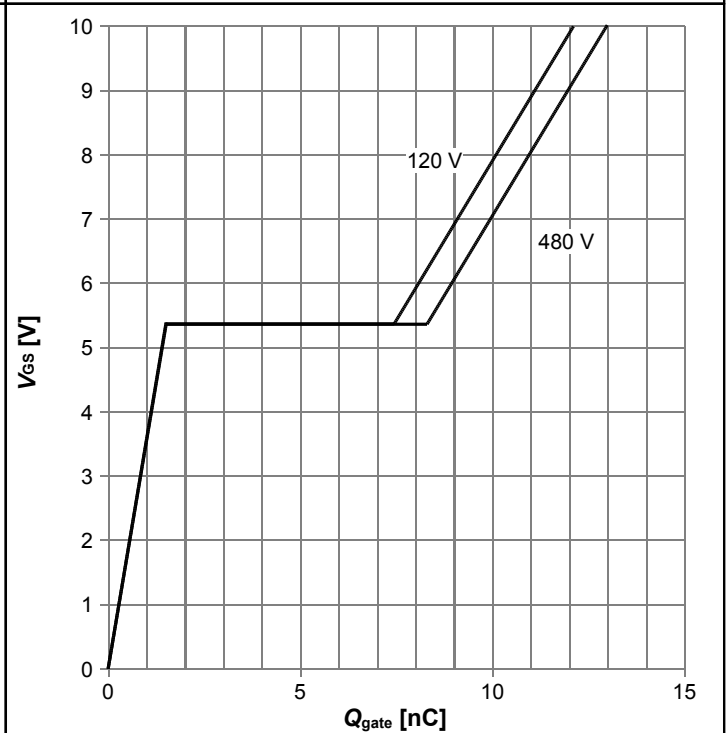
$R_{DS(on)}=f(T_j)$ ;  $I_D=1.5\text{ A}$ ;  $V_{GS}=10\text{ V}$

**Diagram 9: Typ. transfer characteristics**



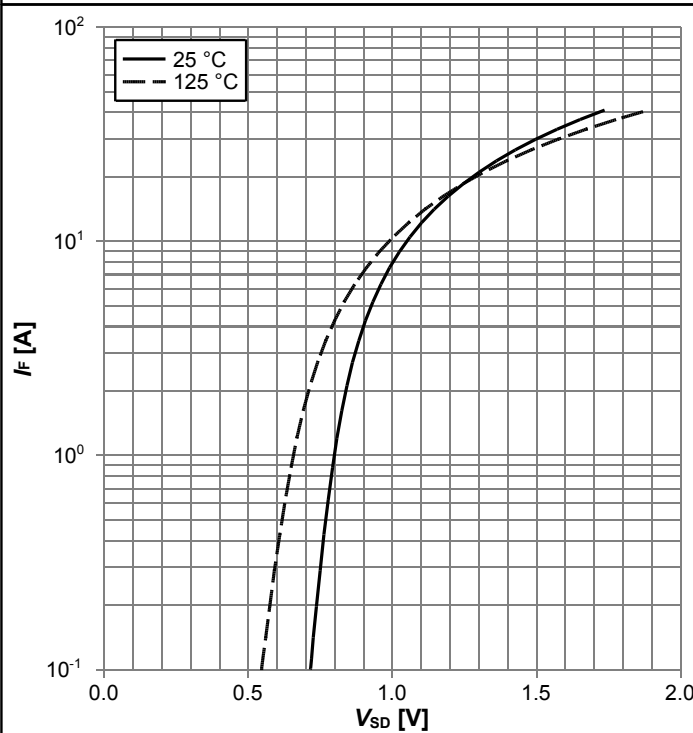
$I_D=f(V_{GS}); V_{DS}=20V; \text{parameter: } T_j$

**Diagram 10: Typ. gate charge**



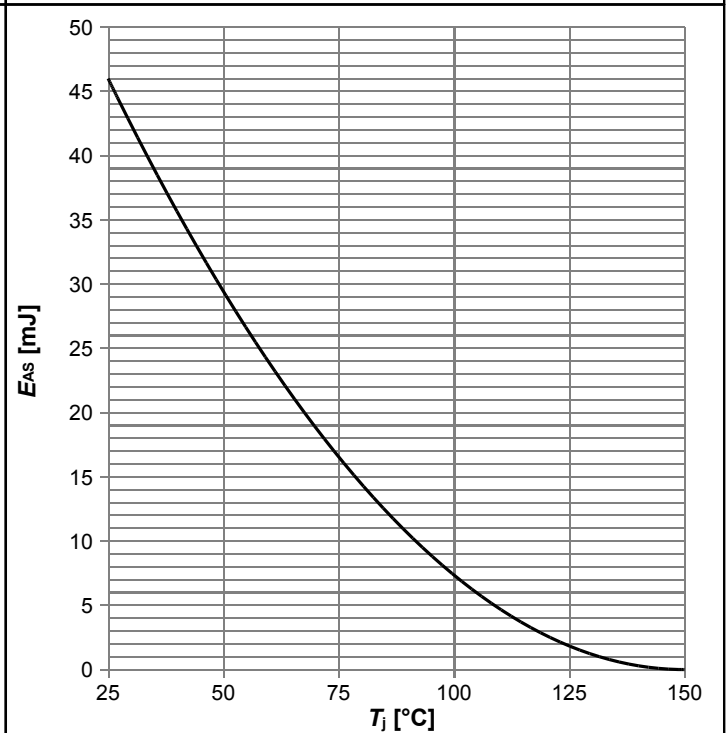
$V_{GS}=f(Q_{gate}); I_D=1.9 \text{ A pulsed}; \text{parameter: } V_{DD}$

**Diagram 11: Forward characteristics of reverse diode**



$I_F=f(V_{SD}); \text{parameter: } T_j$

**Diagram 12: Avalanche energy**



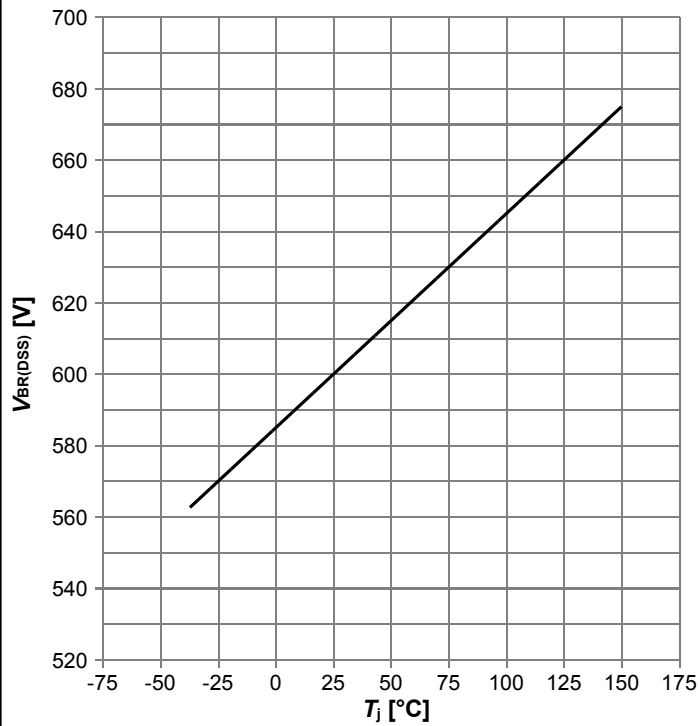
$E_{AS}=f(T_j); I_D=0.8 \text{ A}; V_{DD}=50 \text{ V}$



# 600V CoolMOS™ CE Power Transistor

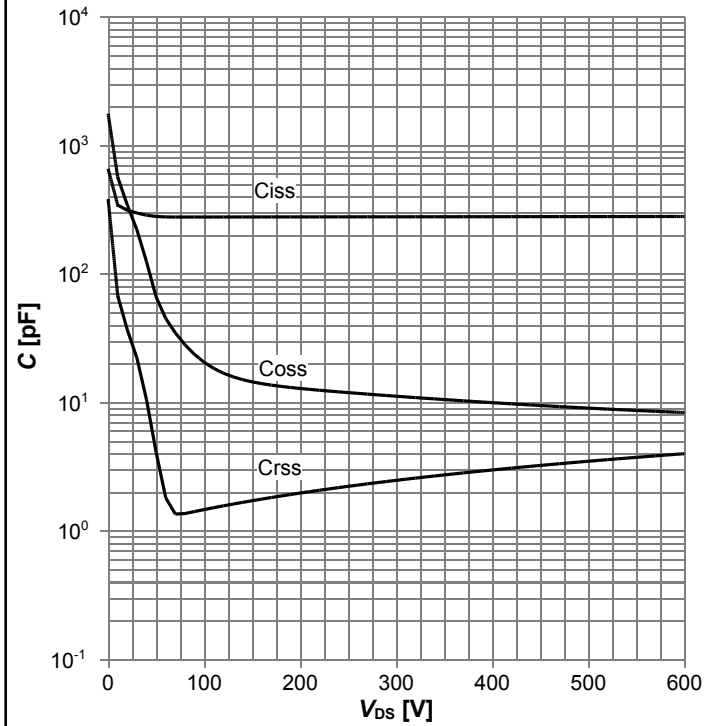
## IPN60R1K0CE

Diagram 13: Drain-source breakdown voltage



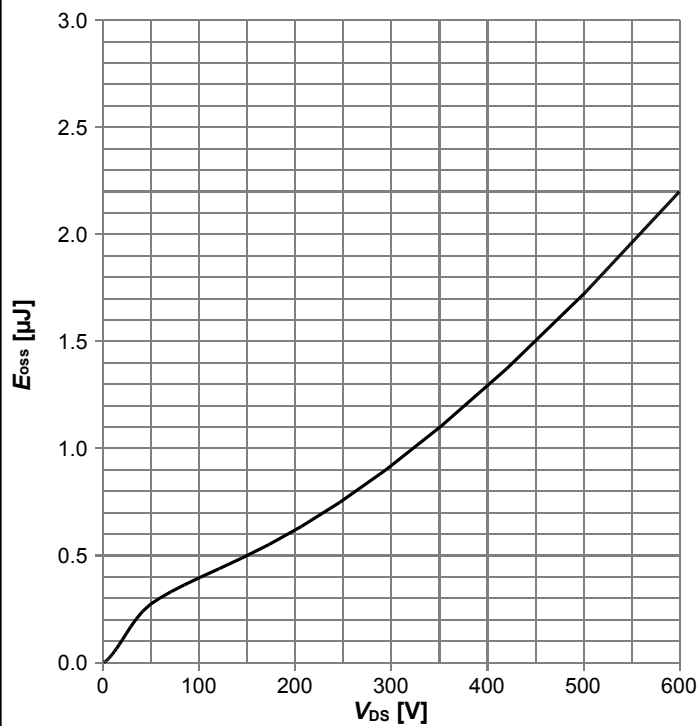
$V_{BR(DSS)} = f(T_j); I_D = 0.25 \text{ mA}$

Diagram 14: Typ. capacitances



$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Diagram 15: Typ. Coss stored energy



$E_{oss} = f(V_{DS})$

## 5 Test Circuits

**Table 8 Diode characteristics**

| Test circuit for diode characteristics | Diode recovery waveform |
|--|-------------------------|
|  |                         |

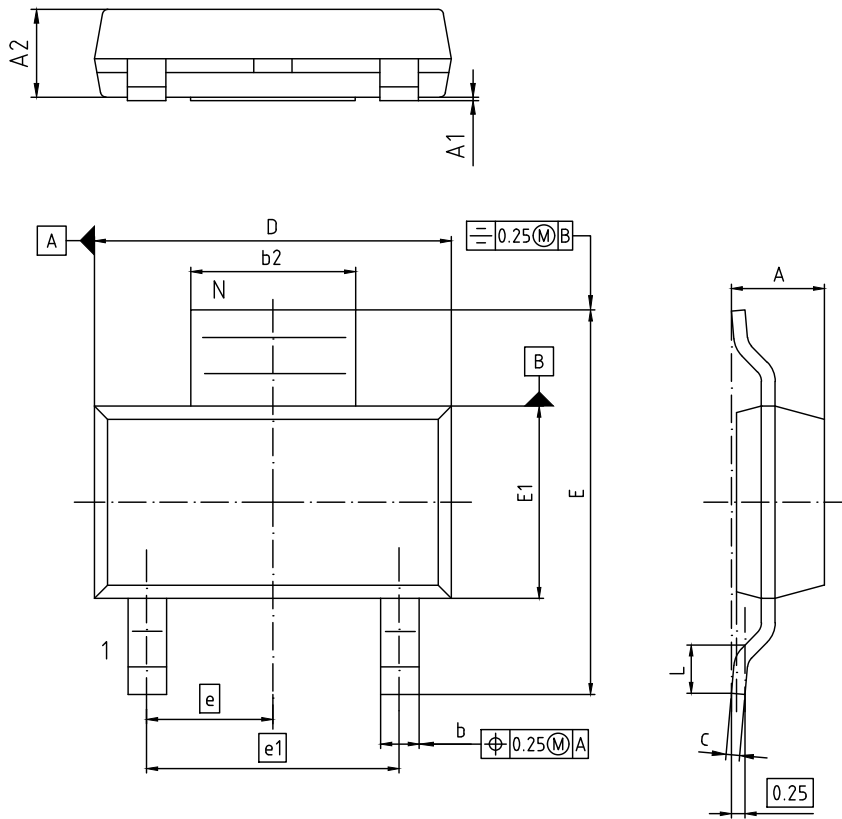
**Table 9 Switching times**

| Switching times test circuit for inductive load | Switching times waveform |
|---|--------------------------|
|   |                          |

**Table 10 Unclamped inductive load**

| Unclamped inductive load test circuit | Unclamped inductive waveform |
|---------------------------------------|------------------------------|
|                                       |                              |

## 6 Package Outlines



NOTES:  
1. ALL DIMENSIONS REFER TO JEDEC STANDARD TO-261

| DIM | MILLIMETERS |      | INCHES      |       |
|-----|-------------|------|-------------|-------|
|     | MIN         | MAX  | MIN         | MAX   |
| A   | 1.52        | 1.80 | 0.060       | 0.071 |
| A1  | -           | 0.10 | -           | 0.004 |
| A2  | 1.50        | 1.70 | 0.059       | 0.067 |
| b   | 0.60        | 0.80 | 0.024       | 0.031 |
| b2  | 2.95        | 3.10 | 0.116       | 0.122 |
| c   | 0.24        | 0.32 | 0.009       | 0.013 |
| D   | 6.30        | 6.70 | 0.248       | 0.264 |
| E   | 6.70        | 7.30 | 0.264       | 0.287 |
| E1  | 3.30        | 3.70 | 0.130       | 0.146 |
| e   | 2.3 BASIC   |      | 0.091 BASIC |       |
| e1  | 4.6 BASIC   |      | 0.181 BASIC |       |
| L   | 0.75        | 1.10 | 0.030       | 0.043 |
| N   | 3           |      | 3           |       |
| O   | 0°          | 10°  | 0°          | 10°   |

|                                    |
|------------------------------------|
| <b>DOCUMENT NO.</b><br>Z8B00180553 |
| <b>SCALE</b><br>0<br>2.5<br>5mm    |
| <b>EUROPEAN PROJECTION</b><br>     |
| <b>ISSUE DATE</b><br>24-02-2016    |
| <b>REVISION</b><br>01              |

Figure 1 Outline PG-SOT223, dimensions in mm/inches

## **7 Appendix A**

### **Table 11 Related Links**

- **IFX CoolMOS Webpage:** [www.infineon.com](http://www.infineon.com)
- **IFX Design tools:** [www.infineon.com](http://www.infineon.com)

# 600V CoolMOS™ CE Power Transistor

## IPN60R1K0CE

### Revision History

IPN60R1K0CE

**Revision: 2016-04-29, Rev. 2.0**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|--|
| 2.0      | 2016-04-29 | Release of final version                     |

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